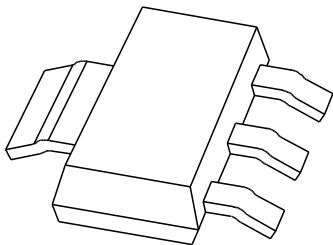


DATA SHEET



PZTM1101

NPN transistor/Schottky-diode module

Product specification
File under Discrete Semiconductors, SC01

1996 May 09

NPN transistor/Schottky-diode module**PZTM1101****FEATURES**

- Low output capacitance
- Fast switching time
- Integrated Schottky protection diode.

APPLICATIONS

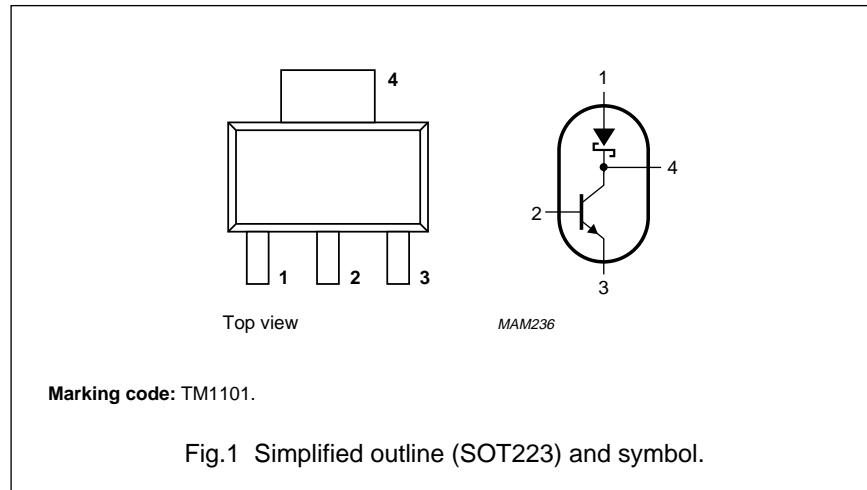
- High-speed switching for industrial applications.

PINNING

PIN	DESCRIPTION
1	anode Schottky
2	base
3	emitter
4	collector, cathode Schottky

DESCRIPTION

Combination of an NPN transistor and a Schottky barrier diode in a plastic SOT223 package. PNP complement: PZTM1102.



Marking code: TM1101.

Fig.1 Simplified outline (SOT223) and symbol.

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
NPN transistor					
V_{CBO}	collector-base voltage	open emitter	–	60	V
V_{CES}	collector-emitter voltage	$V_{BE} = 0$	–	40	V
V_{EBO}	emitter-base voltage	open collector	–	6	V
I_C	collector current (DC)		–	200	mA
Schottky barrier diode					
V_R	continuous reverse voltage		–	40	V
I_F	forward current (DC)		–	1	A
$I_{F(AV)}$	average forward current		–	1	A
T_j	junction temperature	reverse current applied	–	125	°C
		forward current applied	–	150	°C
Combined device					
P_{tot}	total power dissipation	up to $T_{amb} = 25$ °C	–	1.2	W
T_{amb}	operating ambient temperature		–55	+150	°C
T_{stg}	storage temperature		–55	+150	°C
T_j	junction temperature		–	150	°C

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ELECTRICAL CHARACTERISTICS

 $T_{amb} = 25^\circ\text{C}$ unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
NPN transistor					
$V_{(BR)CBO}$	collector-base breakdown voltage	open emitter; $I_C = 10 \mu\text{A}$; $I_E = 0$; $T_{amb} = -55$ to $+150^\circ\text{C}$; note 1	60	—	V
$V_{(BR)CES}$	collector-emitter breakdown voltage	open base; $I_C = 1 \text{ mA}$; $V_{BE} = 0$; $T_{amb} = -55$ to $+150^\circ\text{C}$; note 1	40	—	V
$V_{(BR)EBO}$	emitter-base breakdown voltage	open collector; $I_E = 10 \mu\text{A}$; $I_C = 0$; $T_{amb} = -55$ to $+150^\circ\text{C}$; note 1	6	—	V
I_{CES}	collector-emitter cut-off current	$V_{CE} = 20 \text{ V}$; $V_{BE} = 0$	—	100	nA
		$V_{CE} = 20 \text{ V}$; $V_{BE} = 0$; $T_{amb} = -55$ to $+150^\circ\text{C}$	—	50	μA
I_{EBO}	emitter-base cut-off current	$V_{EB} = 6 \text{ V}$; $I_C = 0$	—	50	nA
		$V_{EB} = 6 \text{ V}$; $I_C = 0$; $T_{amb} = -55$ to $+150^\circ\text{C}$	—	10	μA
V_{CEsat}	collector-emitter saturation voltage	note 1	—	200	mV
		$I_C = 10 \text{ mA}$; $I_B = 1 \text{ mA}$	—	300	mV
		$I_C = 50 \text{ mA}$; $I_B = 3.2 \text{ mA}$	—	—	—
V_{CEsat}	collector-emitter saturation voltage	$T_{amb} = -55$ to $+150^\circ\text{C}$; note 1	—	250	mV
		$I_C = 10 \text{ mA}$; $I_B = 1 \text{ mA}$	—	350	mV
		$I_C = 50 \text{ mA}$; $I_B = 3.2 \text{ mA}$	—	—	—
V_{BEsat}	base-emitter saturation voltage	note 1	—	850	mV
		$I_C = 10 \text{ mA}$; $I_B = 1 \text{ mA}$	—	950	mV
		$I_C = 50 \text{ mA}$; $I_B = 5 \text{ mA}$	—	—	—
V_{BESat}	base-emitter saturation voltage	$T_{amb} = -55$ to $+150^\circ\text{C}$; note 1	—	1000	mV
		$I_C = 10 \text{ mA}$; $I_B = 1 \text{ mA}$	—	1100	mV
		$I_C = 50 \text{ mA}$; $I_B = 5 \text{ mA}$	—	—	—
C_{ob}	output capacitance	$I_E = i_e = 0$; $V_{CB} = 5 \text{ V}$; $f = 1 \text{ MHz}$	—	4	pF
C_{ib}	input capacitance	$I_C = i_c = 0$; $V_{EB} = 0.5 \text{ V}$; $f = 1 \text{ MHz}$	—	8	pF
f_T	transition frequency	$I_C = 10 \text{ mA}$; $V_{CE} = 20 \text{ V}$; $f = 100 \text{ MHz}$	300	—	MHz
h_{FE}	DC current gain	$V_{CE} = 1 \text{ V}$; note 1	—	—	—
		$I_C = 0.1 \text{ mA}$	40	—	—
		$I_C = 1 \text{ mA}$	70	—	—
		$I_C = 10 \text{ mA}$	100	300	—
h_{FE}	DC current gain	$I_C = 100 \text{ mA}$	30	—	—
		$V_{CE} = 1 \text{ V}$; $T_{amb} = -55$ to $+150^\circ\text{C}$; note 1	—	—	—
		$I_C = 10 \text{ mA}$	60	500	—
		$I_C = 100 \text{ mA}$	15	—	—
SWITCHING TIMES (see Figs 2 and 3)					
t_d	delay time	$V_{CC} = 5 \text{ V}$	1	5	ns
t_r	rise time	$I_C = 50 \text{ mA}$	16	31	ns
t_s	storage time	$V_i = 0$ to 5 V	110	310	ns
t_f	fall time		70	100	ns

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SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
Schottky barrier diode					
V_F	forward voltage	$I_F = 100 \text{ mA}$; note 1	—	330	mV
		$I_F = 100 \text{ mA}; T_{\text{amb}} = -55 \text{ to } +150 \text{ }^{\circ}\text{C}$; note 1	—	400	mV
		$I_F = 1 \text{ A}$; note 1	—	500	mV
		$I_F = 1 \text{ A}; T_{\text{amb}} = -55 \text{ to } +150 \text{ }^{\circ}\text{C}$; note 1	—	560	mV
I_R	reverse current	$V_R = 40 \text{ V}$; note 1	—	300	μA
		$V_R = 40 \text{ V}; T_j = 125 \text{ }^{\circ}\text{C}$; $T_{\text{amb}} = -55 \text{ to } +150 \text{ }^{\circ}\text{C}$; note 1	—	35 ⁽²⁾	mA
I_R	reverse current	$V_R = 10 \text{ V}$; note 1	—	40	μA
		$V_R = 10 \text{ V}; T_j = 125 \text{ }^{\circ}\text{C}$; $T_{\text{amb}} = -55 \text{ to } +150 \text{ }^{\circ}\text{C}$; note 1	—	15 ⁽²⁾	mA
C_j	junction capacitance	$V_R = 0 \text{ V}; f = 1 \text{ MHz}$	—	250	pF

Notes

1. Measured under pulsed conditions: $t_p \leq 300 \text{ } \mu\text{s}$; $\delta \leq 0.01$.
2. Limiting value for $T_j = 125 \text{ }^{\circ}\text{C}$; $T_j = 150 \text{ }^{\circ}\text{C}$ with reverse current applied is not allowed as this may cause thermal runaway leading to thermal destruction of the diode. A peak junction temperature of $T_j = 150 \text{ }^{\circ}\text{C}$ is only allowed with forward voltage applied.

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
$R_{\text{th j-a}}$	thermal resistance from junction to ambient (combined device)	note 1	100	K/W

Note

1. Refer to SOT223 standard mounting conditions.

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GRAPHICAL DATA

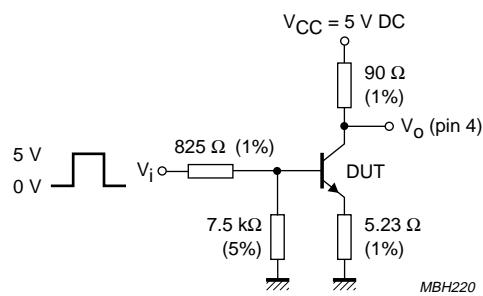
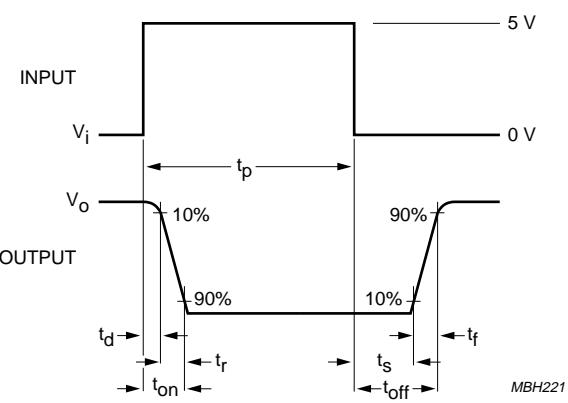


Fig.2 Switching times test circuit.



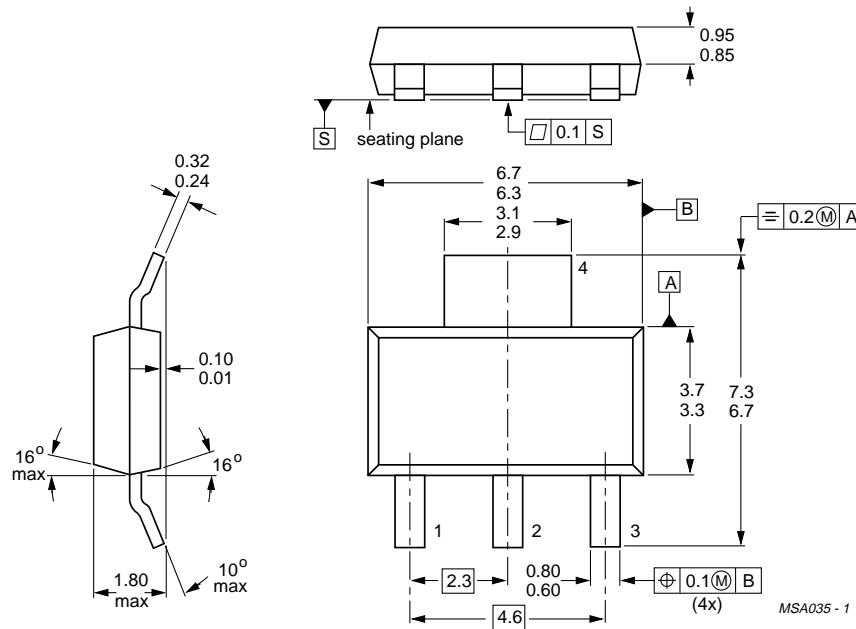
$t_r < 5 \text{ ns}$ (10% to 90%); $t_p = 1 \mu\text{s}$; $\delta = 0.02$; $Z_i = 50 \Omega$.
 $t_{on} = t_d + t_r$; $t_{off} = t_s + t_f$.

Fig.3 Input and output waveforms.

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PACKAGE OUTLINE



Dimensions in mm.

Fig.4 SOT223.

NPN transistor/Schottky-diode module**PZTM1101****DEFINITIONS**

Data sheet status	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
Limiting values	
Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.	
Application information	
Where application information is given, it is advisory and does not form part of the specification.	

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